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JEVANS
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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re patent application of

Kiezo Yamada et al.

Serial No. 09/702,831

Filed November 1, 2000

For SEMICONDUCTOR DEVICE TESTER

Group Art Unit 2829

Examiner Vinh P. Nguyen

Assistant Commissioner for Patents
Washington, D.C. 20231

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TECHNOLOGY CENTER 2800

AMENDMENT UNDER 37 C.F.R. §1.111

Sir:

In response to the Office Action mailed May 2, 2002, please amend the above-identified patent application as follows:

In the Title:

Please substitute the following Title:

A SEMICONDUCTOR DEVICE TESTER WHICH MEASURES
INFORMATION RELATED TO A STRUCTURE OF A SAMPLE IN A DEPTH
DIRECTION

In the Specification:

Please amend the specification as follows. A clean copy of the amended paragraphs is attached.

Please amend the paragraph beginning on page 1, line 22, and continuing to page 2, line 10, as follows: